FAIRCHILD

SEMICONDUCTOR®

FDFME3N311ZT

Integrated N-Channel PowerTrench[®] MOSFET and Schottky Diode **30 V, 1.8 A, 299 m**Ω

Features

- Max $r_{DS(on)}$ = 299 m Ω at V_{GS} = 4.5 V, I_D = 1.6 A
- Max $r_{DS(on)}$ = 410 m Ω at V_{GS} = 2.5 V, I_D = 1.3 A
- Low profile: 0.55 mm maximum in the new package MicroFET 1.6x1.6 Thin
- Free from halogenated compounds and antimony oxides
- HBM ESD protection level > 1600 V (Note 3)
- RoHS Compliant



General Description

This device is designed specifically as a single package solution for a boost topology in cellular handset and other ultra-portable applications. It features a MOSFET with low input capacitance, total gate charge and on-state resistance. An independently connected schottky diode with low forward voltage and reverse leakage current to maximize boost efficiency.

The MicroFET 1.6x1.6 Thin package offers exceptional thermal performance for it's physical size and is well suited to switching and linear mode applications.

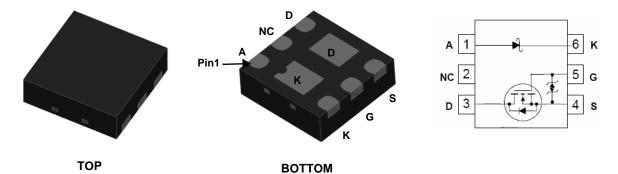
FDFME3N311ZT Integrated N-Channel PowerTrench[®] MOSFET and Schottky Diode

July 2010



Application

Boost Functions



MicroFET 1.6x1.6 Thin

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Parameter | | | Ratings | Units | |
|---|--|------------------------|-----------|-------------|-------|--|
| V _{DS} | Drain to Source Voltage | | | 30 | V | |
| V _{GS} | Gate to Source Voltage | | ±12 | V | | |
| ID | Drain Current -Continuous | T _A = 25 °C | (Note 1a) | 1.8 | Α | |
| | -Pulsed | | | 4.5 | | |
| 6 | Power Dissipation for Single Operation | T _A = 25 °C | (Note 1a) | 1.4 | W | |
| P _D Power Dissipation for Single Operation | | T _A = 25 °C | (Note 1b) | 0.6 | vv | |
| V _{RRM} | Schottky Repetitive Peak Reverse Voltage | | | 28 | V | |
| lo | Schottky Average Forward Current | | | 1 | А | |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range (Note 4 | | (Note 4) | -55 to +150 | °C | |

Thermal Characteristics

| $R_{	ext{	heta}JA}$ | Thermal Resistance, Junction to Ambient (Single Operation) | (Note 1a) | 90 | |
|-----------------------|--|-----------|-----|------|
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction to Ambient (Single Operation) | (Note 1b) | 195 | °C/W |
| R_{\thetaJA} | Thermal Resistance, Junction to Ambient (Single Operation) | (Note 1c) | 110 | C/VV |
| R_{\thetaJA} | Thermal Resistance, Junction to Ambient (Single Operation) | (Note 1d) | 234 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|--------------|-----------------------|-----------|------------|------------|
| 1T | FDFME3N311ZT | MicroFET 1.6x1.6 Thin | 7" | 8mm | 5000 units |

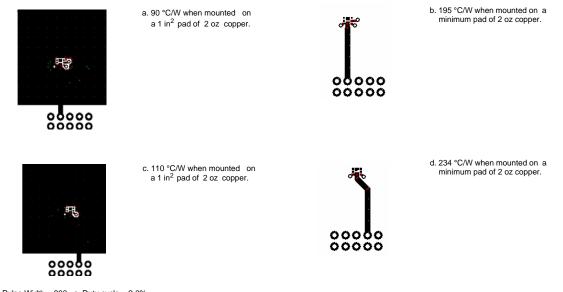
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| Symbol | Parameter | Test | Conditions | Min | Тур | Max | Units |
|--|---|--|--|------|------|------|-------|
| Off Chara | cteristics | | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | I _D = 250 μA, V _{GS} = 0 V | | 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature | $I_D = 250 \ \mu\text{A}$, referenced to 25 °C | | | 25 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 24 V, V | _{GS} = 0 V | | | 1 | μΑ |
| I _{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$ | | | | ±10 | μA |
| On Chara | cteristics | | | | | | |
| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_{D}$ | = 250 μA | 0.5 | 1 | 1.5 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | | eferenced to 25 °C | | -3 | | mV/°C |
| - | | V _{GS} = 4.5 V, I | _D = 1.6 A | | 235 | 299 | |
| r _{DS(on)} | Drain to Source On Resistance | V _{GS} = 2.5 V, | I _D = 1.3 A | | 296 | 410 | mΩ |
| | | V _{GS} = 4.5 V, | _D = 1.6 A,T _J = 125 °C | | 365 | 603 | |
| 9 _{FS} | Forward Transconductance | $V_{DS} = 5 V, I_D =$ | = 1.6 A | | 2.8 | | S |
| Dynamic | Characteristics | | | | | | |
| C _{iss} | Input Capacitance | | | | 55 | 75 | pF |
| C _{oss} | Output Capacitance | $V_{DS} = 15 V, V_{O}$ | _{GS} = 0 V, | | 15 | 20 | pF |
| C _{rss} | Reverse Transfer Capacitance | f = 1 MHz | | | 7 | 10 | pF |
| R _g | Gate Resistance | | | | 7.5 | | Ω |
| Switchind | Characteristics | | | | | | |
| t _{d(on)} | Turn-On Delay Time | | | | 6 | 12 | ns |
| t _r | Rise Time | V _{DD} = 15 V, I _D | | | 8 | 16 | ns |
| t _{d(off)} | Turn-Off Delay Time | – V _{GS} = 4.5 V, F | c _{GEN} = 6 Ω | | 22 | 35 | ns |
| t _f | Fall Time | _ | - | | 1.4 | 10 | ns |
| Q _g | Total Gate Charge | | | | 1 | 1.4 | nC |
| Q _{gs} | Gate to Source Gate Charge | $V_{GS} = 4.5 \text{ V}, V_{DD} = 15 \text{ V},$ | | | 0.2 | | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | I _D = 1.6 A | | | 0.3 | | nC |
| * | Irce Diode Characteristics | | | | | | |
| V _{SD} | Source to Drain Diode Forward Voltage | V _{GS} = 0 V, I _S = | = 0.9 A (Note 2) | | 0.9 | 1.2 | V |
| t _{rr} | Reverse Recovery Time | | | | 12 | 22 | ns |
| Q _{rr} | Reverse Recovery Charge | I _F = 1.6 A, di/c | lt = 100 A/μs | | 3.1 | 10 | nC |
| | Diode Characteristics | | | | | | 1 |
| • | | | T _J = 25 °C | | 15 | 100 | μA |
| I _R | Reverse Leakage | V _R = 28 V | $T_J = 85 \text{ °C}$ | | 0.46 | 4.7 | mA |
| | | | T _J = 25 °C | | 0.47 | 0.57 | |
| V _F | Forward Voltage | $I_F = 1 A$ | T _J = 85 °C | | 0.45 | | V |
| V | Forward Voltage | $I_F = 500 \text{ mA}$ $\begin{array}{c} T_J = 25 \ ^\circ C \\ T_J = 85 \ ^\circ C \end{array}$ | T _J = 25 °C | | 0.38 | 0.48 | V |
| V _F | | | | 0.33 | | v | |
| | | | | | | | |

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Notes:

- 1. R_{0JA} is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0JA} is determined by the user's board design.
 - (a) MOSFET R_{0JA} = 90 °C/W when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB.
 - (b) MOSFET $R_{\theta JA}$ = 195 °C/W when mounted on a minimum pad of 2 oz copper.
 - (c) Schottky R_{0JA} = 110 °C/W when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062" thick PCB.
 - (d) Schottky $R_{\theta JA}$ = 234 °C/W when mounted on a minimum pad of 2 oz copper.

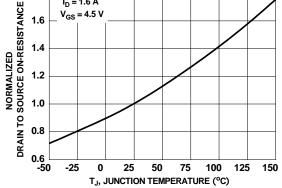


- 2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.
- 4. Rating is applicable to MOSFET only.

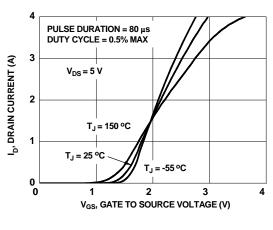
FDFME3N311ZT Integrated N-Channel PowerTrench[®] MOSFET and Schottky Diode

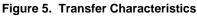
Typical Characteristics T_{.1} = 25°C unless otherwise noted 4 $V_{GS} = 6 V$ NORMALIZED DRAIN TO SOURCE ON-RESISTANCE V_{GS} = 4.5 V V_{GS} = 3.5 V 3 ID, DRAIN CURRENT (A) V_{GS} 3 2 V_{GS} = 2.5 V 1 PULSE DURATION = 80 µs V_{GS} = 1.8 V DUTY CYCLE = 0.5% MAX 0 ō 1 2 3 V_{DS}, DRAIN TO SOURCE VOLTAGE (V) Figure 1. On Region Characteristics 1.8 I_D = 1.6 A V_{GS} = 4.5 V 1.6 1.4 1.2

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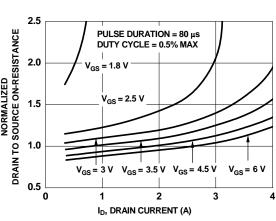
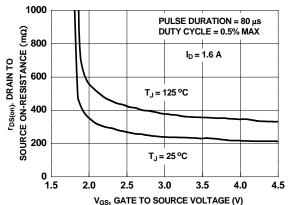
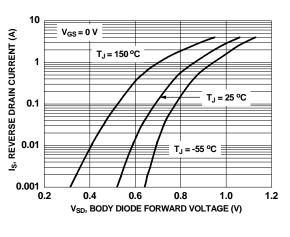
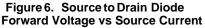


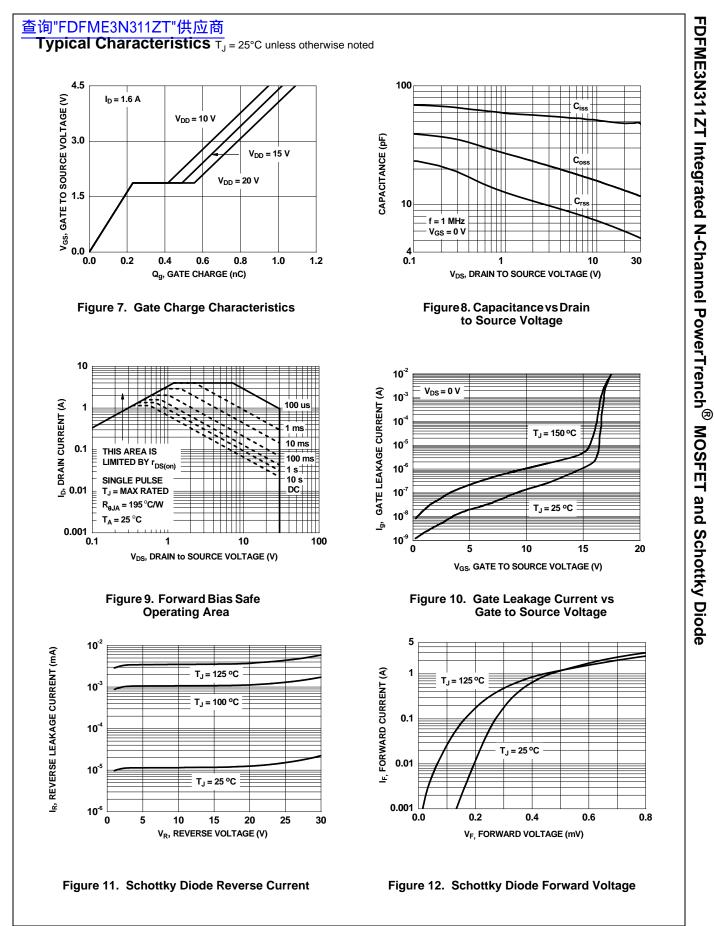
Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

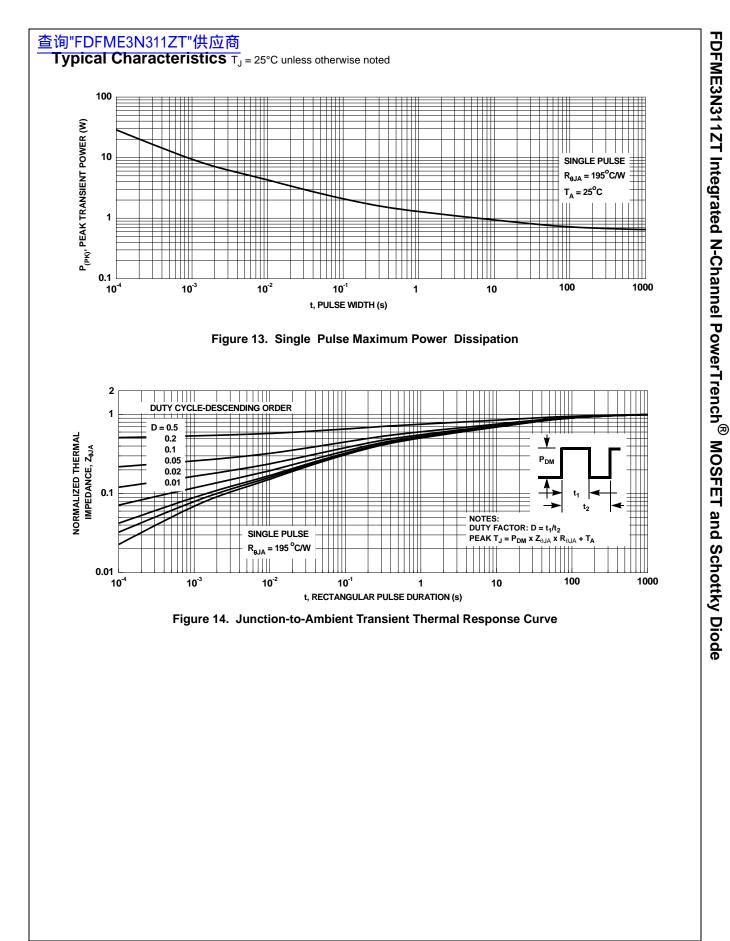


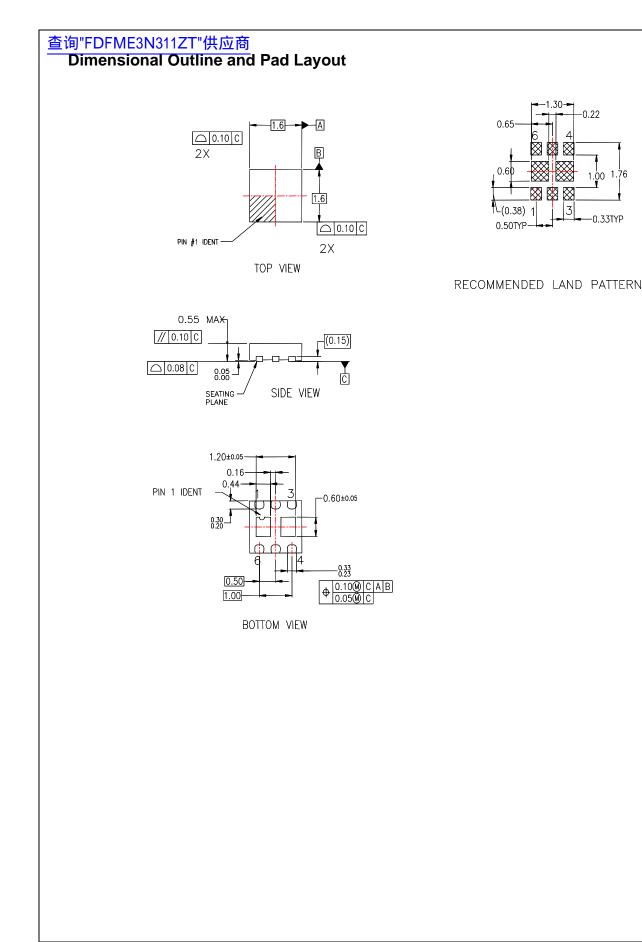












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